

FIG. 2

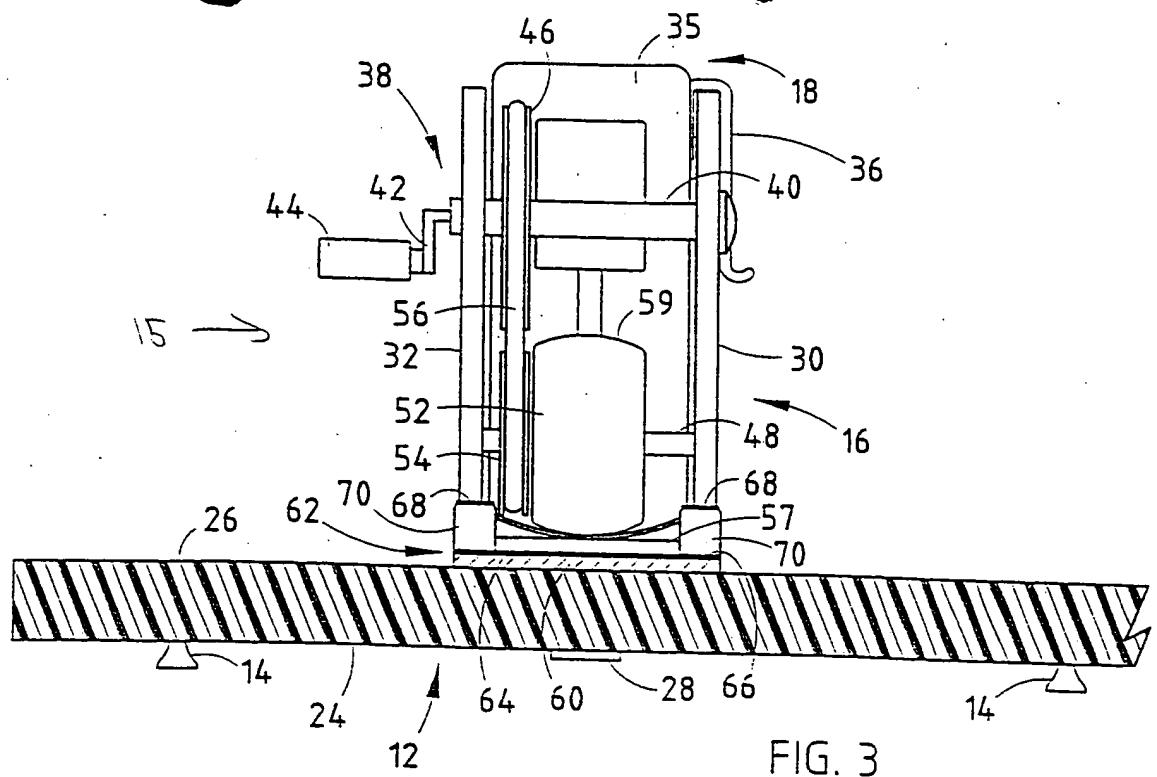


FIG. 3

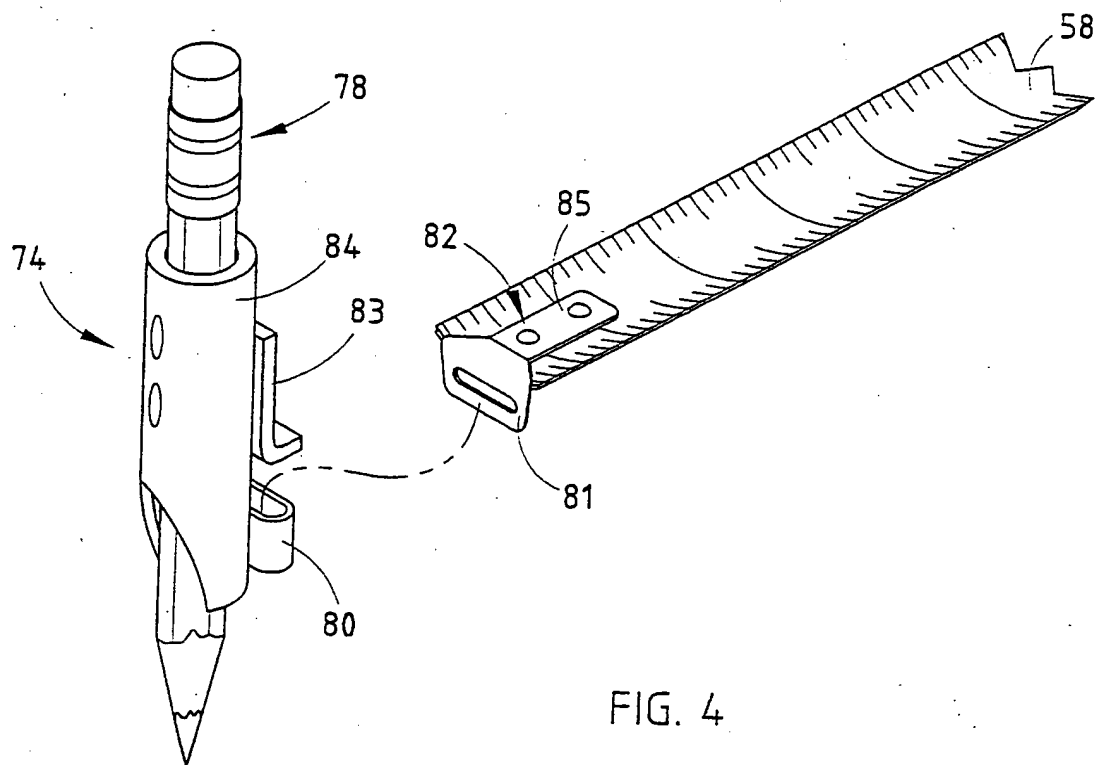


FIG. 4

09505419.024600

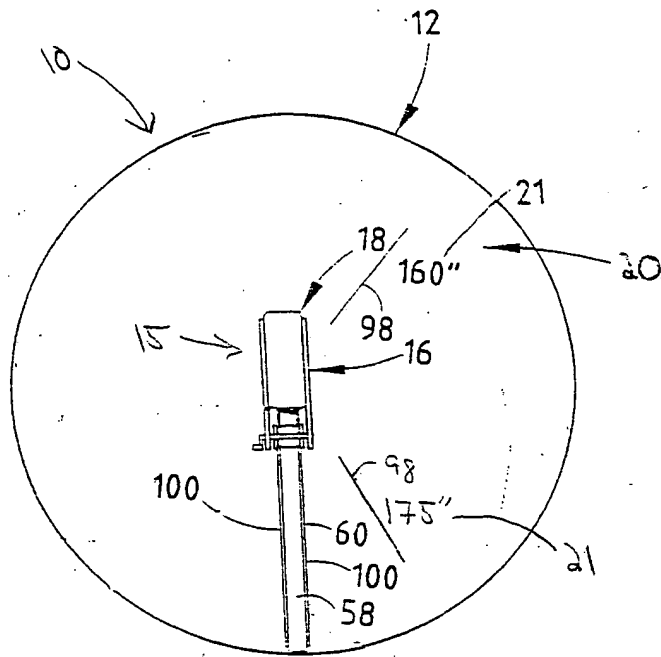
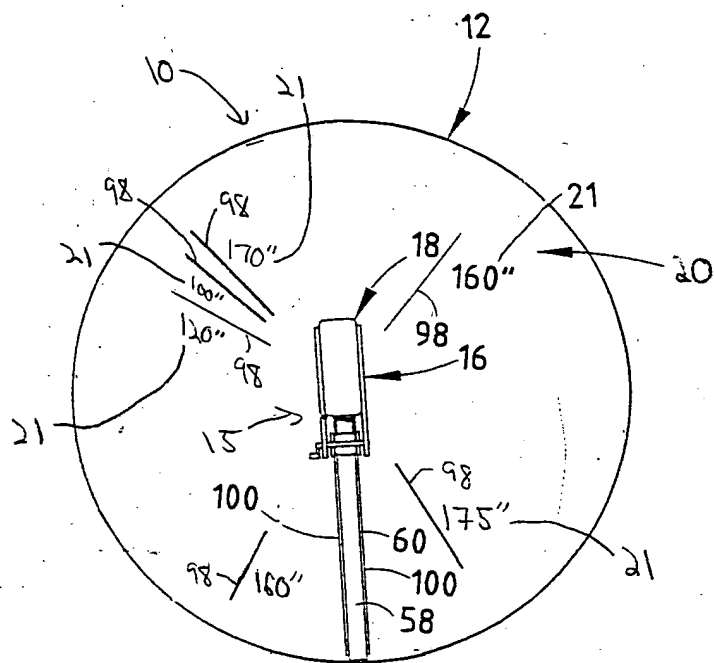
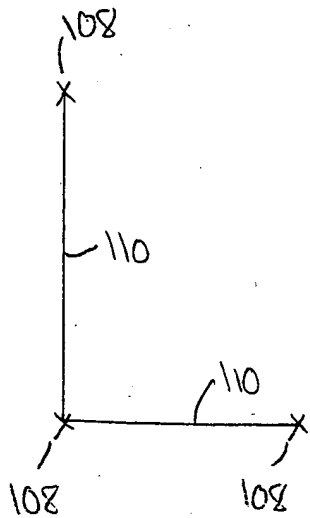


FIG. 5

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FIG. 6

# THE 2000s

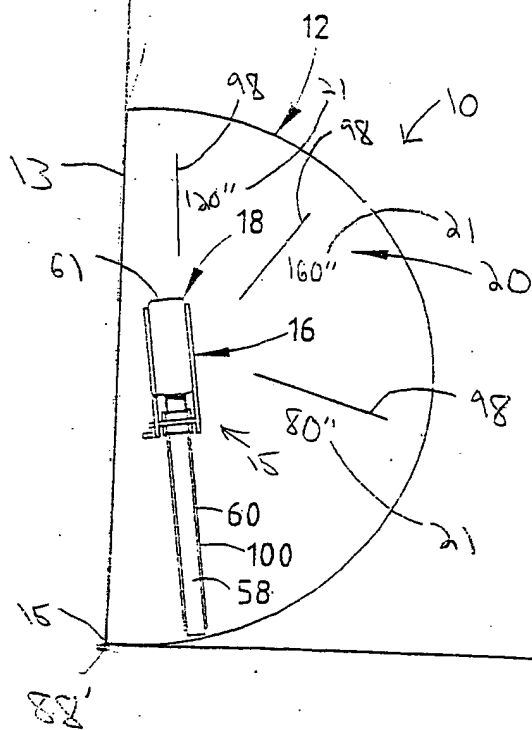


FIG. 7

0950543 001600

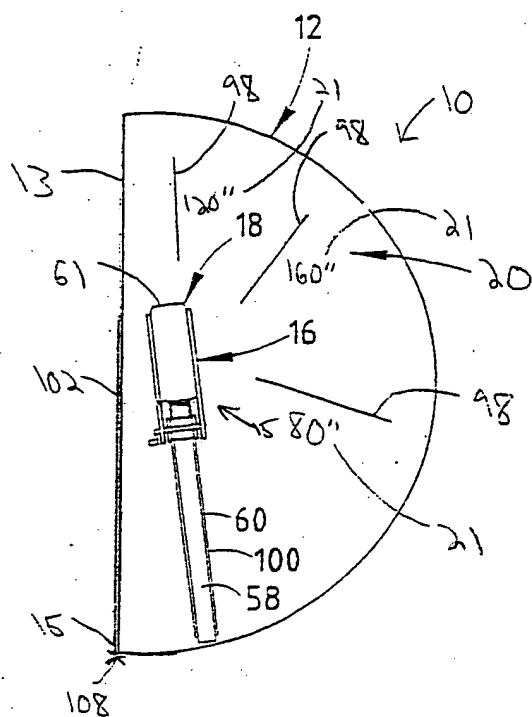


FIG. 8

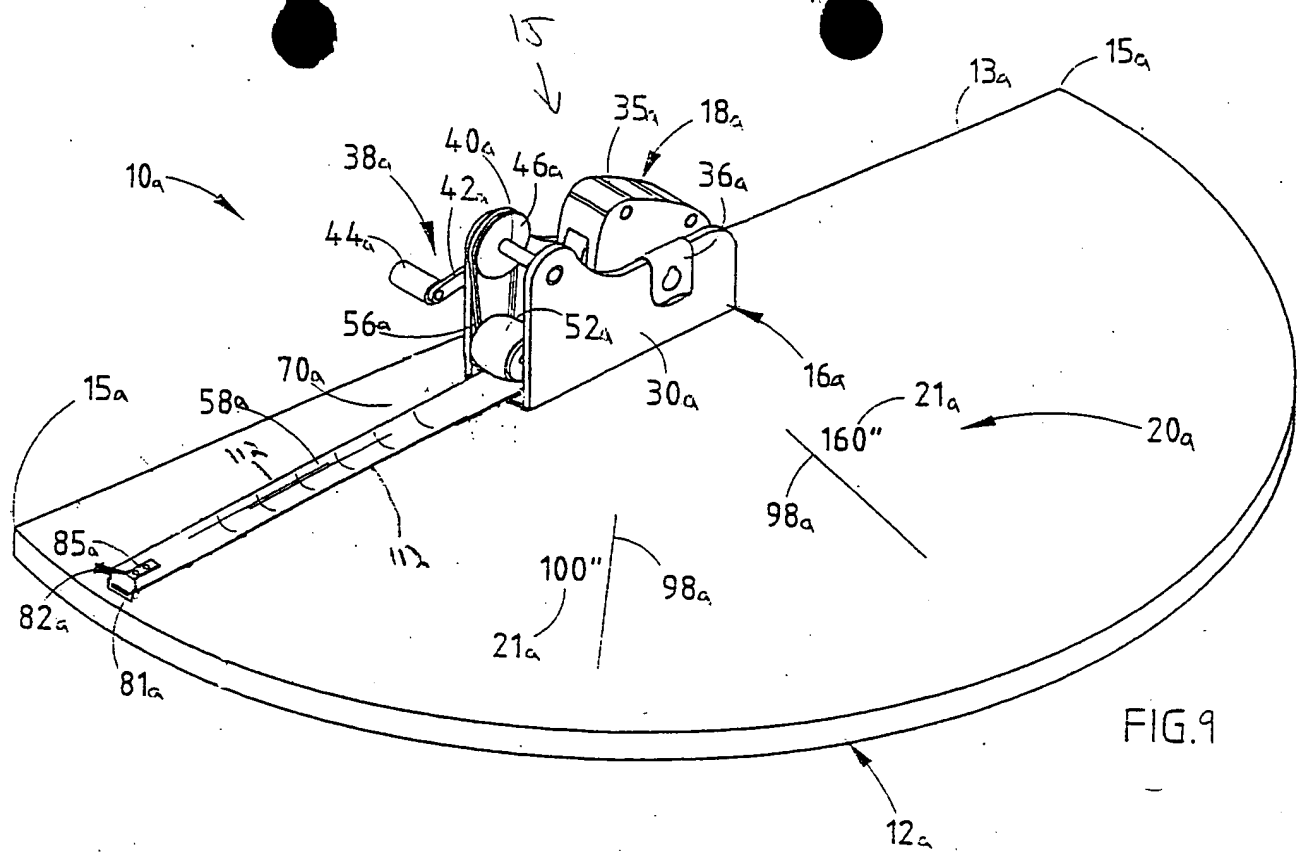


FIG.9

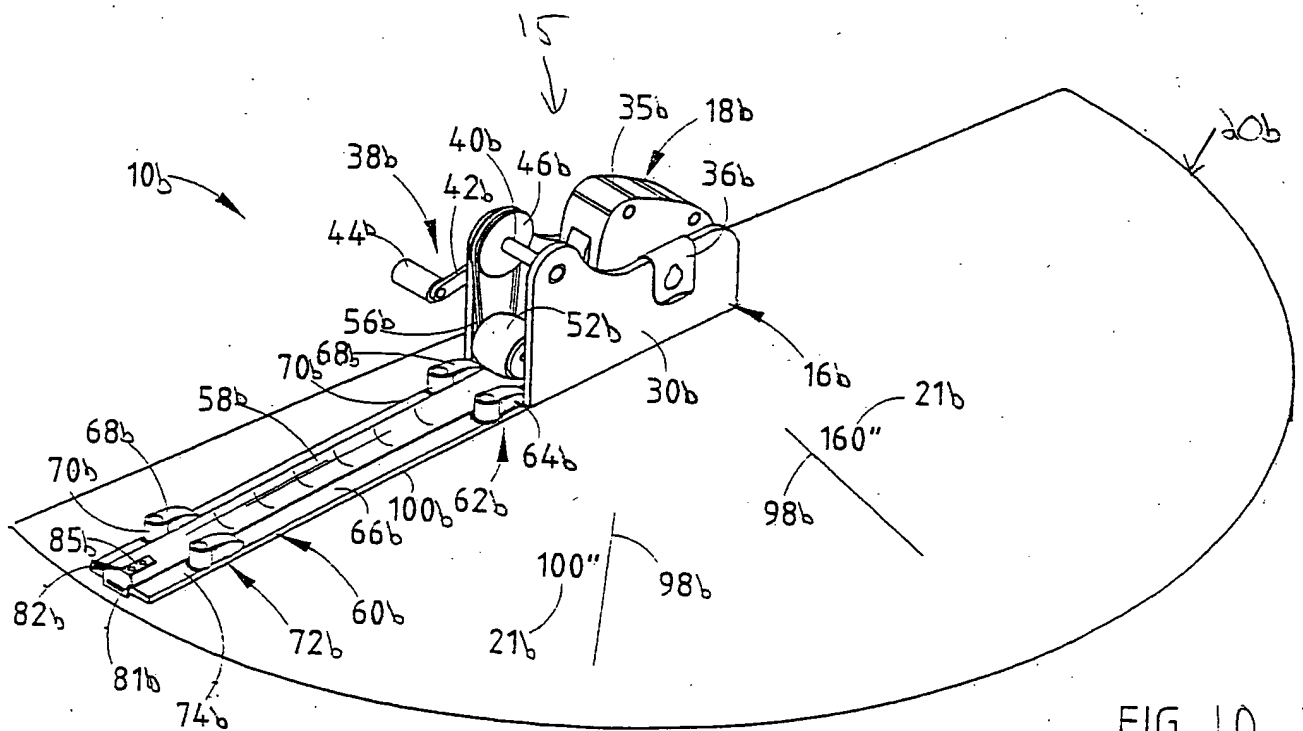
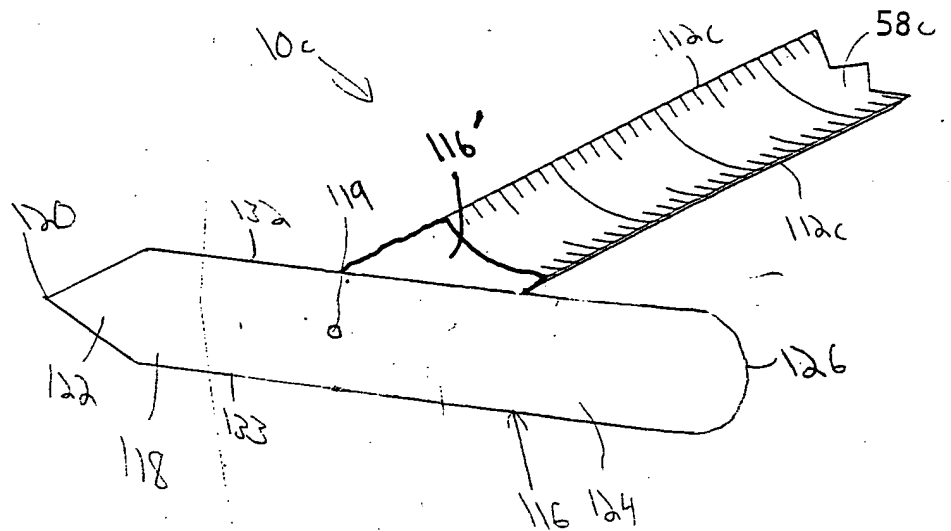
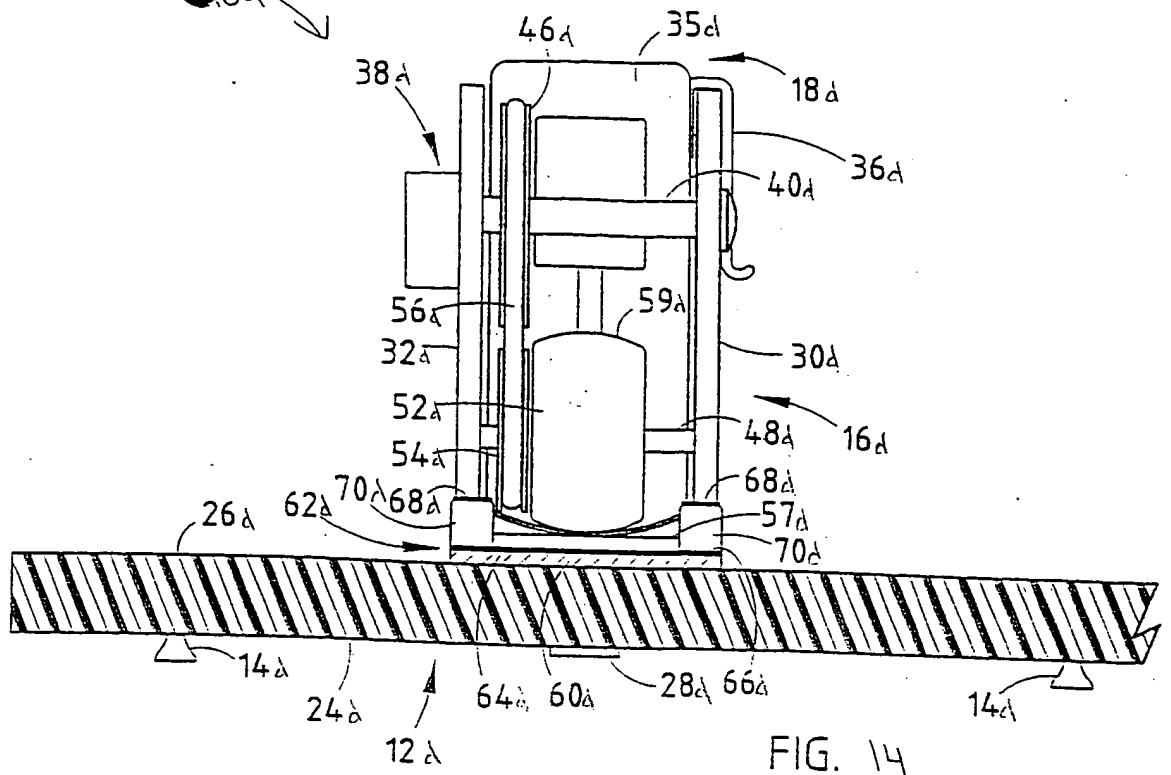


FIG. 10







09505139.021600

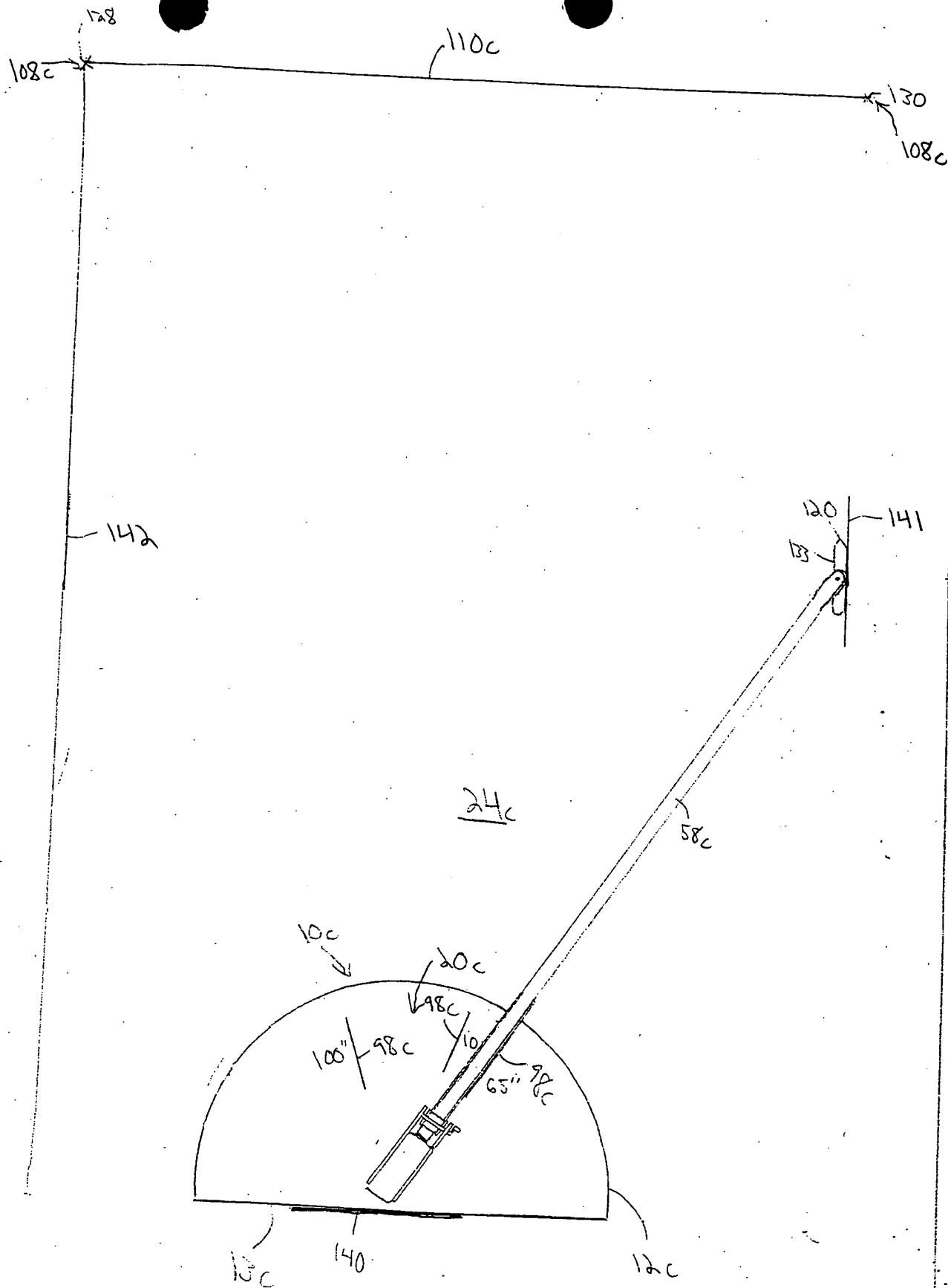


FIG. 13

**THE UNIVERSITY OF CHICAGO**

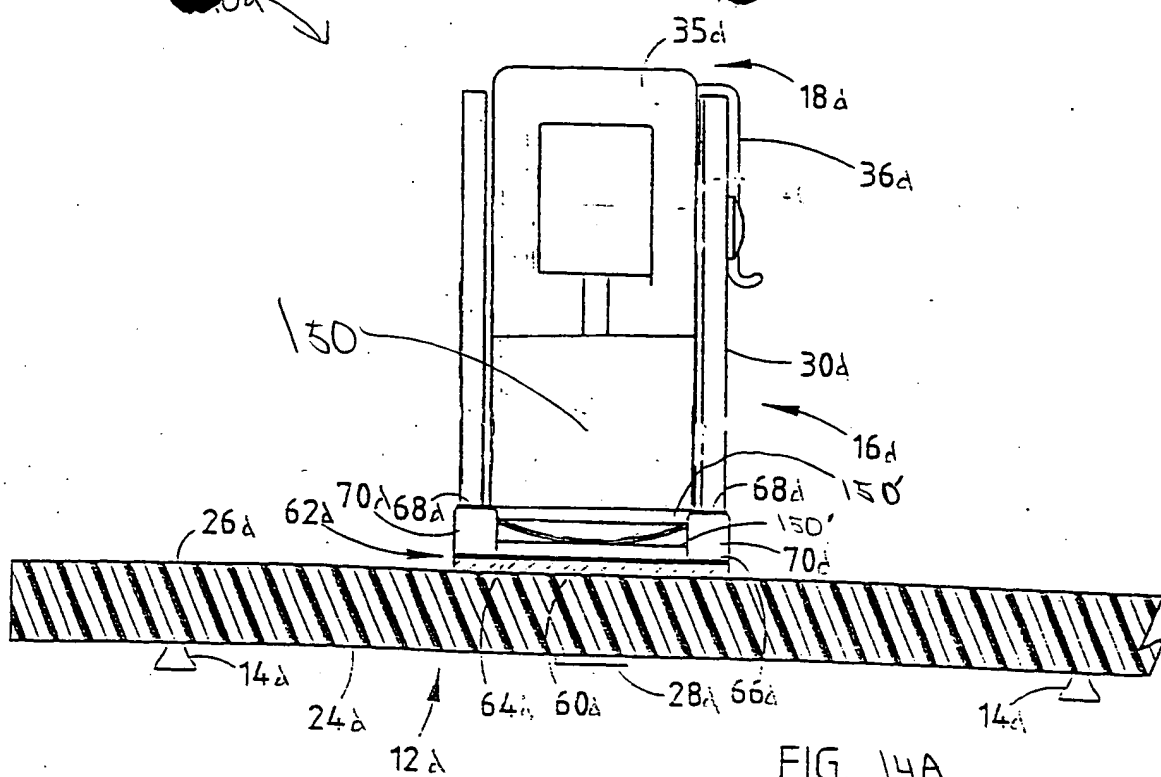


FIG. 14A

Place the template 20e with a center point on the area 22e to be measured.

Create the template 20e using the electronic angle and distance measuring device 15e to measure the angles and the distances from the center point to the critical features 88e of the area 22e.

Record the angles and distances to the critical features 88e on the template 20e.

Obtain a sheet 24e of material to be cut.

Place the template 20e on the sheet 24e of material.

Identify the critical features 88e from the area 22e on the sheet 22e of material based on the feature location information using the angle and distance device 20e.

Cut the sheet 24e of material according to the critical features 88e.

FIG. 15

FIG. 16

